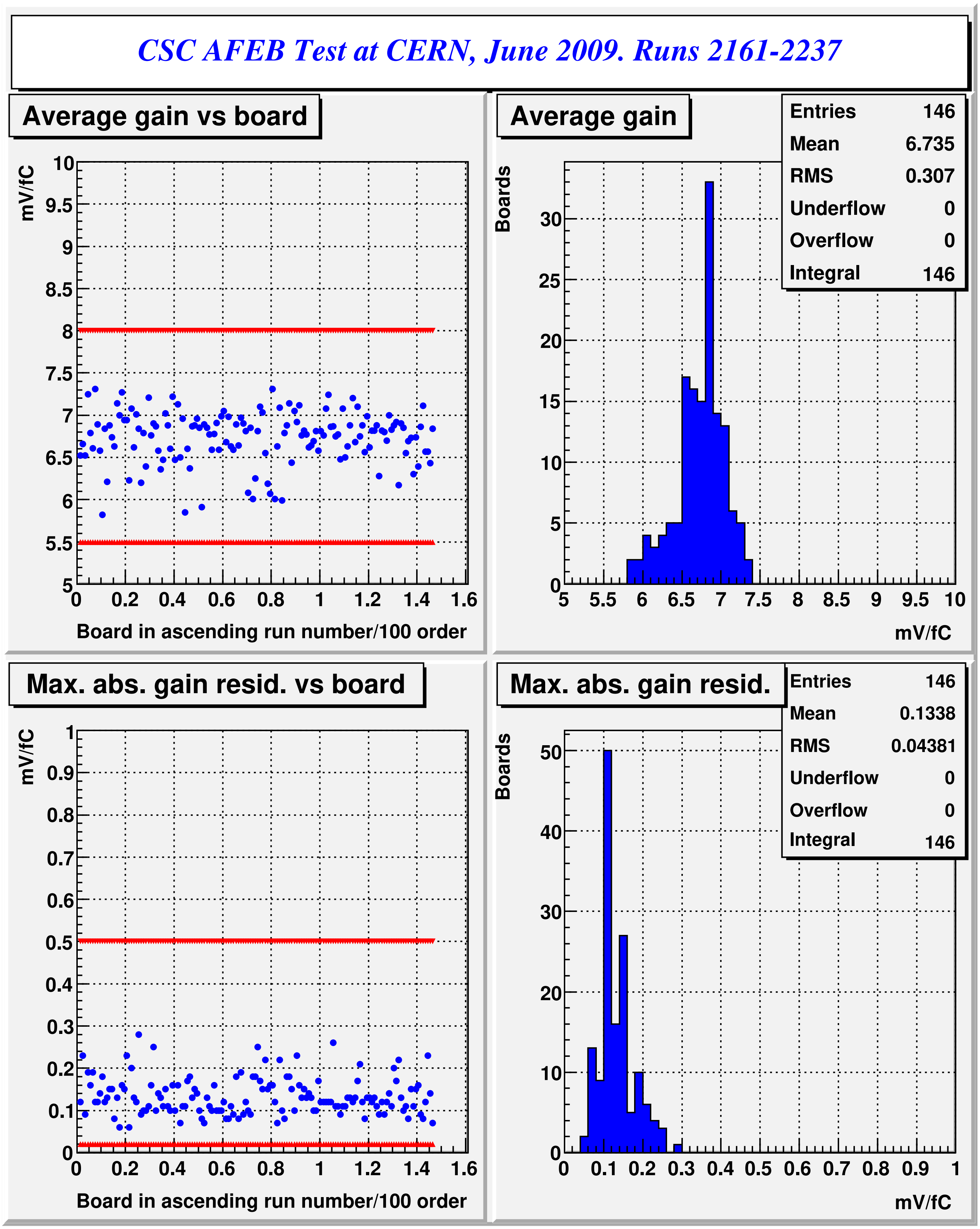
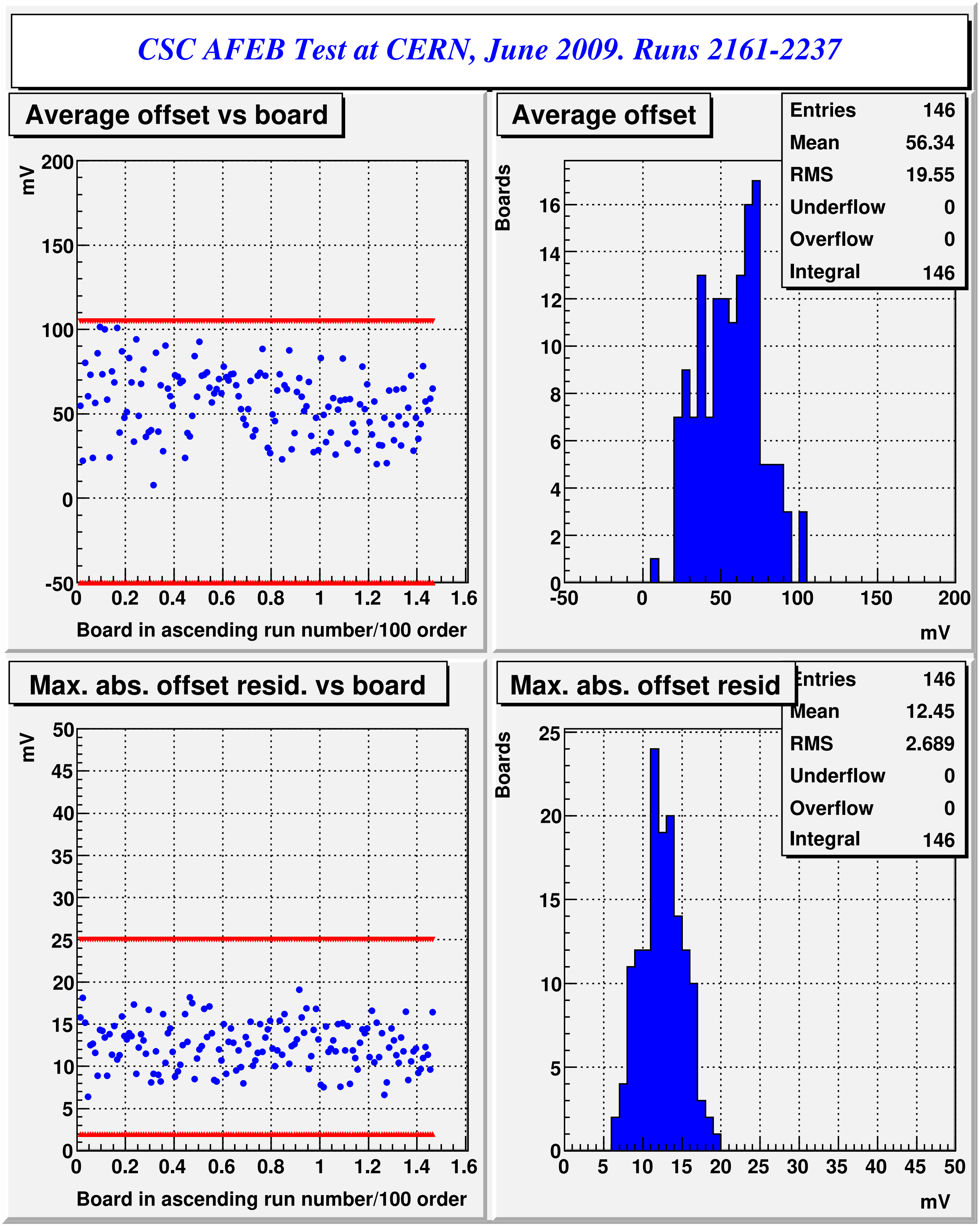
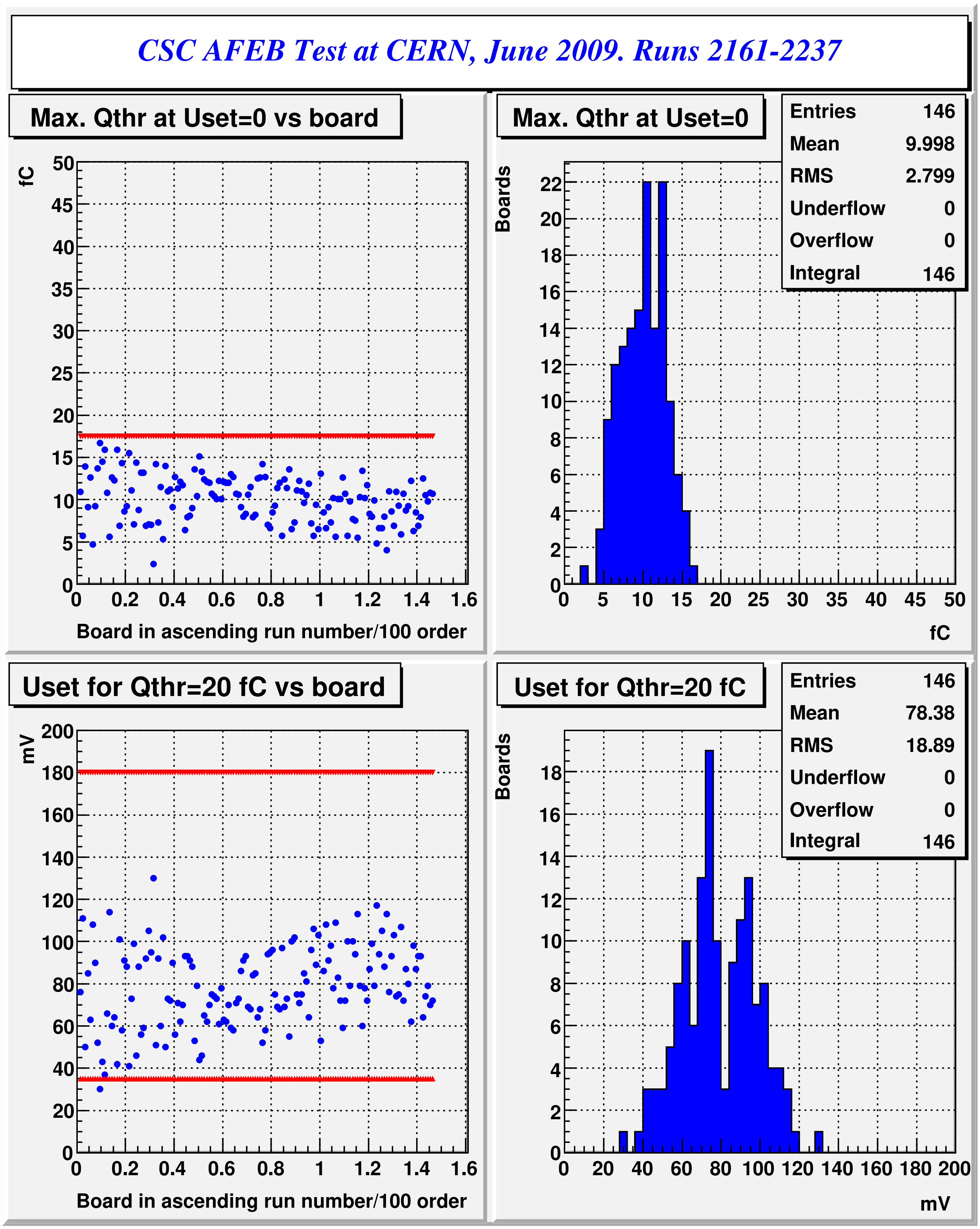

CSC AFEB Test at CERN, June 2009. Runs 2161-2237
Average gain vs board
mV/fC
Board in ascending run number/100 order
Average gain
Boards
mV/fC
Entries 146
Mean 6.735
RMS 0.307
Underflow 0
Overflow 0
Integral 146
Max. abs. gain resid. vs board
mV/fC
Board in ascending run number/100 order
Max. abs. gain resid.
Boards
mV/fC
Entries 146
Mean 0.1338
RMS 0.04381
Underflow 0
Overflow 0
Integral 146


CSC AFEB Test at CERN, June 2009. Runs 2161-2237
Average offset vs board
mV
Board in ascending run number/100 order
Average offset
Boards
mV
Entries 146
Mean 56.34
RMS 19.55
Underflow 0
Overflow 0
Integral 146
Max. abs. offset resid. vs board
mV
Board in ascending run number/100 order
Max. abs. offset resid
Boards
mV
Entries 146
Mean 12.45
RMS 2.689
Underflow 0
Overflow 0
Integral 146


CSC AFEB Test at CERN, June 2009. Runs 2161-2237
Max. Qthr at Uset=0 vs board
fC
Board in ascending run number/100 order
Max. Qthr at Uset=0
Entries 146
Mean 9.998
RMS 2.799
Underflow 0
Overflow 0
Integral 146
Boards
fC
Uset for Qthr=20 fC vs board
mV
Board in ascending run number/100 order
Uset for Qthr=20 fC
Entries 146
Mean 78.38
RMS 18.89
Underflow 0
Overflow 0
Integral 146
Boards
mV